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| Notice of References Cited | Application/Control No. 09/366,064 | Applicant(s)/Patent Under Reexamination MALAURE ET AL. | |
| | Examiner Son P. Huynh | Art Unit 2623 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-2004/0261125 | 12-2004 | Ellis et al. | 725/133 |
| * | B | US-5,555,244 | 09-1996 | Gupta et al. | 370/397 |
| * | C | US-6,442,755 | 08-2002 | Lemmons et al. | 725/47 |
| * | D | US-6,536,041 | 03-2003 | Knudson et al. | 725/39 |
| * | E | US-6,496,862 | 12-2002 | Akatsu et al. | 709/224 |
| * | F | US-5,946,634 | 08-1999 | Korpela, Mikko | 455/552.1 |
| * | G | US-6,181,711 | 01-2001 | Zhang et al. | 370/468 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|--|
| | U | |
| | V | |
| | W | |
| | X | |

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